

**Notice of References Cited**

Application/Control No.

10/763,567

Applicant(s)/Patent Under  
Reexamination  
GILMANSHIN ET AL.

Examiner

KARLHEINZ R. SKOWRONEK

Art Unit

1631

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0039737	04-2002	Chan et al.	435/6
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP0437829	07-1991	US	Sievert	G01N 30/86
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sun (Pattern Recognition Letters Vol. 16, p. 987-996, 1995)
	V	Schwartz et al. (Science, Vol. 262, No. 5130, p. 110-114, 1993)
	W	Dousseau et al. (Applied Spectroscopy, Vol. 43, No. 3, p. 538-542, 1989)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.